

Form PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				ATTY. DOCKET NO. M122-2391		SERIAL NO. 10/678,513		
				APPLICANT Werner Juengling				
				FILING DATE 10/3/03		GROUP 2823		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate
<i>BN</i>	AA	5,821,140	10/13/98	Joss et al.				
<i>BN</i>	AB	5,017,506	05/21/91	Shen et al.				
<i>BN</i>	AC	6,177,339 B1	01/23/01	Juengling				
<i>BN</i>	AD	5,985,711	11/16/99	Lim				
<i>BN</i>	AE	5,856,227	01/05/99	Yu et al.				
<i>BN</i>	AF	5,731,236	03/24/98	Chou et al.				
<i>BN</i>	AG	5,668,065	09/16/97	Lin				
<i>BN</i>	AH	5,637,525	06/10/97	Dennison				
<i>BN</i>	AI	5,459,085	10/17/95	Pasan et al.				
<i>BN</i>	AJ	4,734,383	03/29/88	Ikeda et al.				
<i>BN</i>	AK	4,343,657	08/10/82	Ito et al.				
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
<i>BN</i>	AL							
<i>BN</i>	AM							
<i>BN</i>	AN							
<i>BN</i>	AO							
<i>BN</i>	AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
<i>BN</i>	AR		Microchip Fabrication - Second Edition , McGraw-Hill ©1990, page 332 only.					
<i>BN</i>	AS		Wolf, Ph.D. et al., Silicon Processing for the VLSI Era - Vol. 1 - Process Technology, ©1986, page 283 only.					
	AT							
EXAMINER <i>Enon Kekeda</i>			DATE CONSIDERED 10/17/2004					
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>								

Form PTO-1449				U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2391		SERIAL NO. 10/678,513	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Werner Juengling					
				FILING DATE 10/31/03		GROUP 282-3			
U.S. PATENT DOCUMENTS									
*Examiner Initial		Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate	
<i>BU</i>	AA	4,232,439	11/11/80	Shibata					
<i>BU</i>	AB	6,015,730	01/18/00	Wang et al.					
<i>BU</i>	AC	5,731,242	03/24/98	Parai et al.					
<i>BU</i>	AD	6,025,255	02/15/00	Chen					
<i>BU</i>	AE	5,795,809	08/18/98	Gardner et al.					
<i>BU</i>	AF	5,766,992	06/16/98	Chou et al.					
<i>BU</i>	AG	5,686,324	11/11/97	Wang et al.					
<i>BU</i>	AH	5,656,520	08/12/97	Watanabe					
<i>BU</i>	AI	6,165,880	12/26/00	Yaung et al.					
<i>BU</i>	AJ	6,337,261	01/08/02	Juengling					
<i>BU</i>	AK	6,093,629	07/25/00	Chen					
<i>BU</i>	AL	5,206,187	04/27/93	Doan et al.					
<i>BU</i>	AM	5,015,594	05/14/91	Chu et al.					
FOREIGN PATENT DOCUMENTS									
		Document Number	Date	Country		Class	Subclass	Translation	
								Yes	No
	AN								
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)									
	AO								
	AP								
	AQ								
EXAMINER <i>Brook Kebede</i>				DATE CONSIDERED <i>10/17/2004</i>					
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